

April 1995 Revised August 1999

### 74FR2245

## **Octal Bidirectional Transceiver with 3-STATE Outputs**

#### **General Description**

The 74FR2245 contains eight non-inverting bidirectional buffers with 3-STATE outputs and is intended for bus-oriented applications. Current sinking capability is 64 mA on the A Port. The Transmit/Receive (T/R) input determines the direction of data flow through the bidirectional transceiver. Transmit (active-HIGH) enables data from A Ports to B Ports; Receive (active-LOW) enables data from B Ports to A Ports. The Output Enable input, when HIGH, disables both A and B Ports by placing them in a High Z condition.

#### **Features**

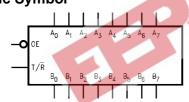
- Non-inverting buffers
- Bidirectional data path
- Guaranteed pin-to-pin skew
- 25Ω series resistors in B outputs eliminate the need for external resistors
- 3-STATE outputs drive bus lines or buffer memory address resistors

#### **Ordering Code:**

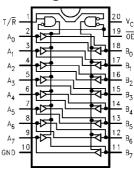
Order Number	Package Number	Package Description					
74FR2245SC	M20B	20-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-013, 0.300 Wide					

Devices also available in Tape and Reel. Specify by appending the suffix letter "X" letter to the ordering code.

## **Logic Symbol**



#### **Connection Diagram**



#### **Pin Descriptions**

Pin Names	Description			
ŌĒ	Output Enable Input (Active-LOW)			
T/R	Transmit/Receive Input			
A <sub>0</sub> -A <sub>7</sub>	Side A Inputs or 3-STATE Outputs			
B <sub>0</sub> -B <sub>7</sub>	Side B Inputs or 3-STATE Outputs			

#### **Truth Table**

Inp	outs	Output
OE	T/R	
L	L	Bus B Data to Bus A
L	Н	Bus A Data to Bus B
Н	Χ	High Z State

H = HIGH Voltage Level

L = LOW Voltage Level

## Absolute Maximum Ratings(Note 1)

Storage Temperature  $-65^{\circ}\text{C to } +150^{\circ}\text{C}$ 

 $\begin{tabular}{lll} Ambient Temperature under Bias & -55^{\circ}C to +125^{\circ}C \\ Junction Temperature under Bias & -55^{\circ}C to +150^{\circ}C \\ V_{CC} Pin Potential to Ground Pin & -0.5V to +7.0V \\ \end{tabular}$ 

Input Voltage (Note 2) -0.5 V to +7.0 V Input Current (Note 2) -30 mA to +5.0 mA

Voltage Applied to Output in HIGH State (with  $V_{CC} = 0V$ )

Standard Output -0.5V to  $V_{CC}$ 3-STATE Output -0.5V to +5.5V

Current Applied to Output

in LOW State (Max) twice the rated  $I_{OL}$  (mA) ESD Last Passing Voltage (Min) 4000V

# Recommended Operating Conditions

Free Air Ambient Temperature  $0^{\circ}\text{C to } +70^{\circ}\text{C}$ Supply Voltage +4.5V to +5.5V

**Note 1:** Absolute maximum ratings are values beyond which the device may be damaged or have its useful life impaired. Functional operation under these conditions is not implied.

Note 2: Either voltage limit or current limit is sufficient to protect inputs.

#### **DC Electrical Characteristics**

Symbol	Parameter	Min	Тур	Max	Units	V <sub>CC</sub>	Conditions
V <sub>IH</sub>	Input HIGH Voltage	2.0			V	50	Recognized HIGH Signal
V <sub>IL</sub>	Input LOW Voltage			0.8	1 V		Recognized LOW Signal
V <sub>CD</sub>	Input Clamp Diode Voltage			-1.2	V	Min	I <sub>IN</sub> = -18 mA
V <sub>OH</sub>	Output HIGH Voltage	2.4		CIL	V	Min	$I_{OH} = -3 \text{ mA } (A_n, B_n)$
		2.0			V	Min	$I_{OH} = -15 \text{ mA } (A_n, B_n)$
V <sub>OL</sub>	Output LOW Voltage	-		0.5	V	Max	$I_{OL} = 1 \text{ mA } (B_n)$
				0.75	V	Max	$I_{OL} = 12 \text{ mA } (B_n)$
				0.55	V	Max	$I_{OL} = 64 \text{ mA } (A_n)$
I <sub>IH</sub>	Input HIGH Current			5	μΑ	Max	$V_{IN} = 2.7V (\overline{OE}, T/\overline{R})$
I <sub>BVI</sub>	Input HIGH Current			7		Max	$V_{IN} = 7.0 V (\overline{OE}, T/\overline{R})$
	Breakdown Test			1	μΑ	IVIAX	V <sub>IN</sub> = 7.0V (OE, 1/R)
I <sub>BVIT</sub>	Input HIGH Current			400			V 55V/A D)
	Breakdown Test (I/O)			100	μΑ	Max	$V_{IN} = 5.5V (A_n, B_n)$
I <sub>IL</sub>	Input LOW Current			-250	μΑ	Max	$V_{IN} = 0.5V (\overline{OE}, T/\overline{R})$
V <sub>ID</sub>	Input Leakage Test	4.75			V	0.0	$I_{ID} = 1.9 \mu A$
							All Other Pins Grounded
I <sub>OD</sub>	Output Circuit Leakage Current			3.75	μΑ	0.0	V <sub>IOD</sub> = 150 mV
							All Other Pins Grounded
I <sub>IH</sub> + I <sub>OZH</sub>	Output Leakage Current			25	μΑ	Max	$V_{OUT} = 2.7V (A_n, B_n)$
I <sub>IL</sub> + I <sub>OZL</sub>	Output Leakage Current			-150	μΑ	Max	$V_{OUT} = 0.5V (A_n, B_n)$
Ios	Output Short-Circuit Current	-100		-225	mA	Max	$V_{OUT} = 0.0V (A_n, B_n)$
I <sub>CEX</sub>	Output HIGH Leakage Current			50	μΑ	Max	$V_{OUT} = V_{CC} (A_n, B_n)$
I <sub>ZZ</sub>	Bus Drainage Test			100	μΑ	0.0	$V_{OUT} = 5.25V (A_n, B_n)$
I <sub>CCH</sub>	Power Supply Current		55	75	mA	Max	All Outputs HIGH
I <sub>CCL</sub>	Power Supply Current		75	110	mA	Max	All Outputs LOW
I <sub>CCZ</sub>	Power Supply Current		55	75	mA	Max	Outputs 3-STATE
C <sub>IN</sub>	Input Capacitance		8.0		pF	5.0	OE, T/R
			17.0		pF	5.0	A <sub>n</sub> , B <sub>n</sub>

## **AC Electrical Characteristics**

Symbol	Parameter		$T_{A} = +25^{\circ}C$ $V_{CC} = +5.0V$ $C_{L} = 50 \text{ pF}$			$T_A = 0$ °C to $+70$ °C $V_{CC} = +5.0$ V $C_L = 50$ pF		
		Min	Тур	Max	Min	Max	1	
t <sub>PLH</sub>	Propagation Delay	1.0		4.4	1.0	4.4	ns	
t <sub>PHL</sub>	A <sub>n</sub> to B <sub>n</sub> or B <sub>n</sub> to A <sub>n</sub>	1.0		4.4	1.0	4.4	110	
t <sub>PZH</sub>	Output Enable Time	2.5		7.5	2.5	7.5		
$t_{PZL}$		2.5		7.5	2.5	7.5	ns	
t <sub>PHZ</sub>	Output Disable Time	1.7		6.5	1.7	6.5	20	
$t_{PLZ}$		1.7		6.5	1.7	6.5	ns	

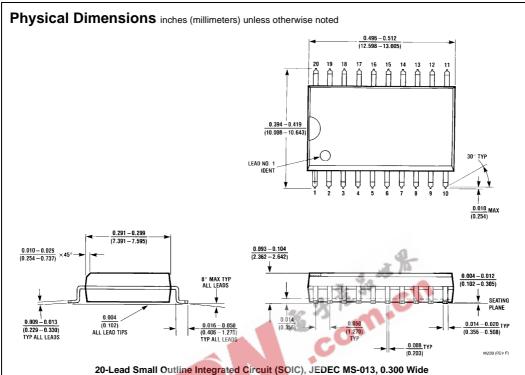
#### **Extended AC Electrical Characteristics**

Symbol	Parameter	T <sub>A</sub> = 0°C to +70°C		T <sub>A</sub> = 0°C to +70°C		Units
		V <sub>CC</sub> = +	5.0V	V <sub>CC</sub> = +5.0V C <sub>L</sub> = 250 pF		
		C <sub>L</sub> = 50	) pF			
		Eight Outputs	Switching	(No	ote 4)	
		(Note	3)	129		
		Min	Max	Min	Max	
t <sub>PLH</sub>	Propagation Delay	1.0	7.0	2.5	10.0	ns
$t_{PHL}$	$A_n$ to $B_n$ or $B_n$ to $A_n$	1.0	7.0	2.5	10.0	115
t <sub>PZH</sub>	Output Enable Time	2.5	10.0			ns
$t_{PZL}$		2.5	10.0			113
t <sub>PHZ</sub>	Output Disable Time	1.3	6.5			ns
$t_{PLZ}$		1.3	6.5			110
toshl	Pin-to-Pin Skew		1.7			ns
(Note 5)	for HL Transitions		1.7			113
toslh	Pin-to-Pin Skew		1.0			ns
(Note 5)	for LH Transitions		1.0			113
t <sub>OST</sub>	Pin-to-Pin Skew		3.3			ns
(Note 5)	for HL/LH Transitions		0.0			

Note 3: This specification is guaranteed but not tested. The limits apply to propagation delays for all paths described switching in phase, i.e., all LOW-to-HIGH, HIGH-to-LOW, 3-STATE-to-HIGH, etc.

Note 4: These specifications guaranteed but not tested. The limits represent propagation delays with 250 pF load capacitors in place of the 50 pF load capacitors in the standard AC load. This specification pertains to single output switching only.

Note 5: Skew is defined as the absolute value of the difference between the actual propagation delays for any two outputs of the same device. The specification applies to any outputs switching HIGH-to-LOW (t<sub>OSHL</sub>), LOW-to-HIGH (t<sub>OSL</sub>), or HIGH-to-LOW and/or LOW-to-HIGH (t<sub>OST</sub>). Specifications guaranteed with all outputs switching in phase.



Package Number M20B

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